

FEATURES

- Micropower
1.5 μ W (1 Sample/Second)
- Power Supply Flexibility
Single Supply 2.8V to 16V
Split Supply ± 2.8 V to ± 8 V
- *Guaranteed* Max Offset 0.75mV
- *Guaranteed* Max Tracking Error Between Input Pairs $\pm 0.1\%$
- Input Common Mode Range to Both Supply Rails
- TTL/CMOS Compatible with ± 5 V or Single 5V Supply
- Input Errors are Stable with Time and Temperature

APPLICATIONS

- Battery-Powered Systems
- Remote Sensing
- Window Comparator
- BANG-BANG Controllers

DESCRIPTION

The LTC[®]1040 is a monolithic CMOS dual comparator manufactured using Linear Technology's enhanced LTCMOS[™] silicon gate process. Extremely low operating power levels are achieved by internally switching the comparator ON for short periods of time. The CMOS output logic holds the output information continuously while not consuming any power.

In addition to switching power ON, a switched output is provided to drive external loads during the comparator's active time. This allows not only low comparator power, but low total system power.

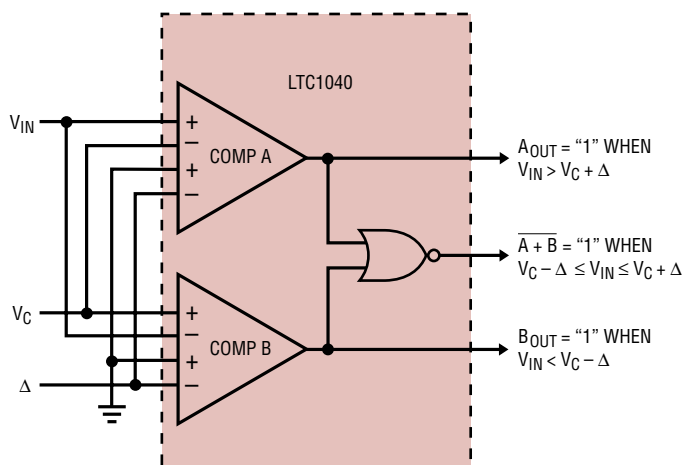
Sampling is controlled by an external strobe input or an internal oscillator. The oscillator frequency is set by an external RC network.

Each comparator has a unique input structure, giving two differential inputs. The output of the comparator will be high if the algebraic sum of the inputs is positive and low if the algebraic sum of the inputs is negative.

LT, LTC and LT are registered trademarks of Linear Technology Corporation.
LTCMOS[™] is a trademark of Linear Technology Corporation.

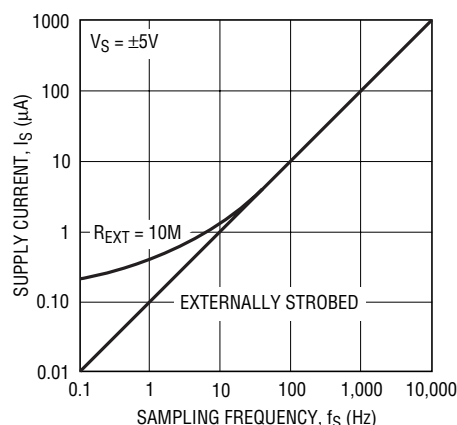
TYPICAL APPLICATION

Window Comparator with Symmetric Window Limits



LTC1040 • TA01

Typical LTC1040 Supply Current
vs Sampling Frequency



LTC1040 • TA02

LTC1040

ABSOLUTE MAXIMUM RATINGS

(Note 1)

Total Supply Voltage (V^+ to V^-)	18V
Input Voltage	($V^+ + 0.3V$) to ($V^- - 0.3V$)
Operating Temperature Range	
LTC1040C	$-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$
LTC1040M (OBSOLETE)	-55°C to 125°C
Storage Temperature Range	-55°C to 150°C
Lead Temperature (Soldering, 10 sec)	300°C
Output Short-Circuit Duration	Continuous

PACKAGE/ORDER INFORMATION

TOP VIEW			ORDER PART NUMBER		
STROBE	1		18	V ⁺	LTC1040CN LTC1040CSW
ON/ $\overline{\text{OFF}}$	2		17	V _{P-P}	
A + B	3		16	OSC	
A _{OUT}	4		15	B _{OUT}	
A1 ⁺	5		14	B1 ⁺	
A1 ⁻	6		13	B1 ⁻	
A2 ⁺	7		12	B2 ⁺	
A2 ⁻	8		11	B2 ⁻	
GND	9		10	V ⁻	
N PACKAGE 18-LEAD PDIP		SW PACKAGE 18-LEAD PLASTIC SO WIDE			
$T_{J\text{MAX}} = 110^{\circ}\text{C}$, $\theta_{JA} = 120^{\circ}\text{C/W}$ (N) $T_{J\text{MAX}} = 125^{\circ}\text{C}$, $\theta_{JA} = 85^{\circ}\text{C/W}$ (SW)					
J PACKAGE 18-LEAD CERP $T_{J\text{MAX}} = 150^{\circ}\text{C}$, $\theta_{JA} = 80^{\circ}\text{C/W}$					
OBSOLETE PACKAGE					
Consider the N18 Package as an Alternate Source					

Consult LTC Marketing for parts specified with wider operating temperature ranges.

ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^\circ\text{C}$. Test conditions: $V^+ = 5V$, $V^- = -5V$, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS		LTC1040M/LTC1040C			UNITS
				MIN	TYP	MAX	
V_{OS}	Offset Voltage (Note 2)	Split Supplies $\pm 2.8V$ to $\pm 6V$ Single Supply ($V^- = GND$) 2.8V to 6V	●		± 0.3	± 0.75	mV
		Split Supplies $\pm 6V$ to $\pm 8V$ Single Supply ($V^- = GND$) 6V to 15V	●		± 1	± 4.5	mV
	Tracking Error Between Input Pairs (Notes 2 and 3)	Split Supplies $\pm 2.8V$ to $\pm 8V$ Single Supplies ($V^- = GND$) 2.8 to 16V	●		0.05	0.1	%
I_{BIAS}	Input Bias Current	OSC = GND			± 0.3		nA
R_{IN}	Average Input Resistance	$f_S = 1\text{kHz}$ (Note 4)	●	20	30		M Ω
CMR	Common Mode Range		●	V^-		V^+	V
PSR	Power Supply Range	Split Supplies	●	± 2.8		± 8	V
		Single Supplies ($V^- = GND$)	●	2.8		16	V
$I_{S(ON)}$	Power Supply ON Current (Note 5)	$V^+ = 5V$, V_{P-P} On	●		1.2	3	mA
$I_{S(OFF)}$	Power Supply OFF Current (Note 5)	$V^+ = 5V$, V_{P-P} Off	●		0.001	0.5	μA
		LTC1040C LTC1040M	●		0.001	5	μA
t_D	Response Time (Note 6)			60	80	100	μs
V_{OH} V_{OL}	A, B, $\overline{A+B}$ and ON/OFF Outputs (Note 7) Logic "1" Output Voltage Logic "0" Output Voltage	$V^+ = 4.75V$, $I_{OUT} = -360\mu\text{A}$	●	2.4	4.4		V
		$V^+ = 4.75V$, $I_{OUT} = 1.6\text{mA}$	●		0.25	0.4	V

1040fa

ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range otherwise specifications are at $T_A = 25^\circ\text{C}$. Test conditions: $V^+ = 5\text{V}$, $V^- = -5\text{V}$, unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	LTC1040M/LTC1040C			UNITS
			MIN	TYP	MAX	
V_{IH}	STROBE Input (Note 7) Logic "1" Input Voltage	$V^+ = 5.25\text{V}$	2.0	1.6	0.8	V
V_{IL}	Logic "0" Input Voltage	$V^+ = 4.75\text{V}$		1.0		V
R_{EXT}	External Timing Resistor	Resistor Tied Between V^+ and OSC Pin	100		10,000	k Ω
f_S	Sampling Frequency	$R_{EXT} = 1\text{M}$, $C_{EXT} = 0.1\mu\text{F}$		5		Hz

Note 1: Absolute Maximum Ratings are those values beyond which the life of a device may be impaired.

Note 2: Applies over input voltage range limit and includes gain uncertainty.

Note 3: Tracking error = $(V_{IN1} - V_{IN2}) / V_{IN1}$.

Note 4: R_{IN} is guaranteed by design and is not tested.

$R_{IN} = 1/(f_S \cdot 33\text{pF})$.

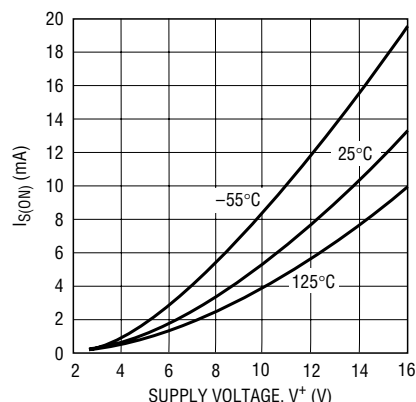
Note 5: Average supply current = $t_D \cdot I_{S(ON)} \cdot f_S + (1 - t_D \cdot f_S) \cdot I_{S(OFF)}$.

Note 6: Response time is set by an internal oscillator and is independent of overdrive voltage.

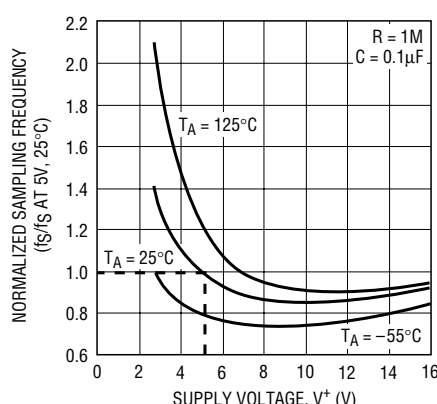
Note 7: Inputs and outputs also capable of meeting EIA/JEDEC B series CMOS specifications.

TYPICAL PERFORMANCE CHARACTERISTICS

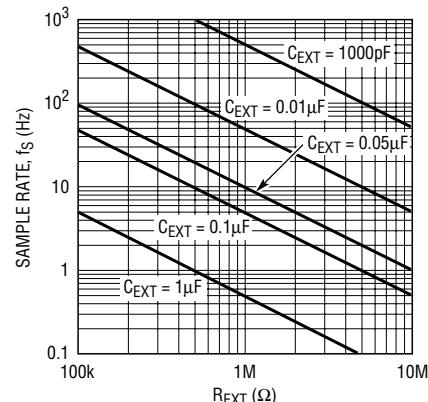
Peak Supply Current
vs Supply Voltage



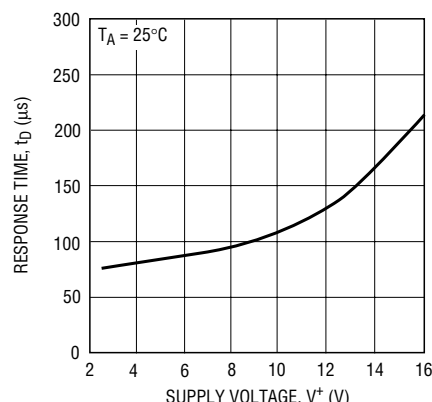
Normalized Sampling Frequency
vs Supply Voltage and Temperature



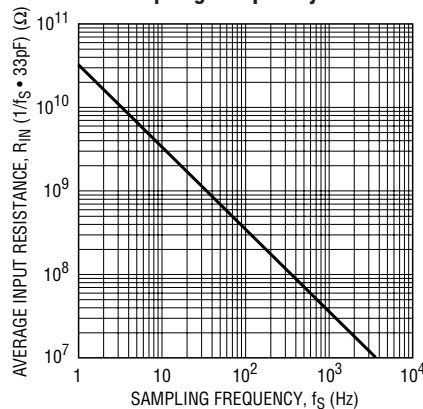
Sampling Rate vs R_{EXT} , C_{EXT}



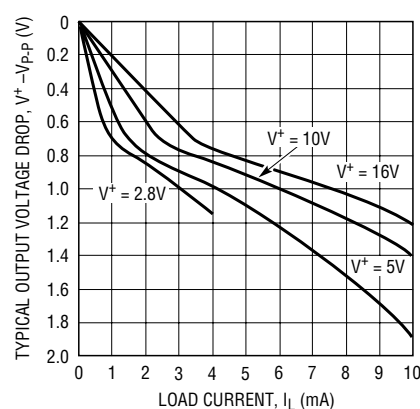
Response Time
vs Supply Voltage



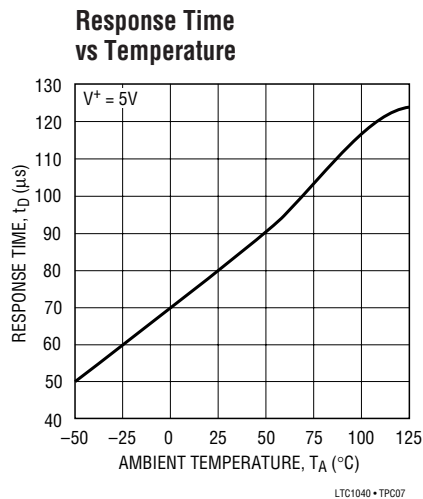
Input Resistance
vs Sampling Frequency



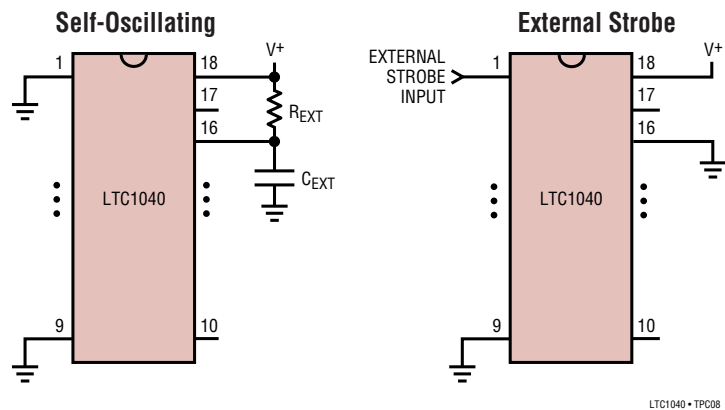
V_{P-P} Output Voltage
vs Load Current



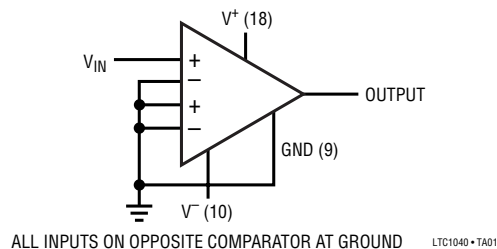
TYPICAL PERFORMANCE CHARACTERISTICS



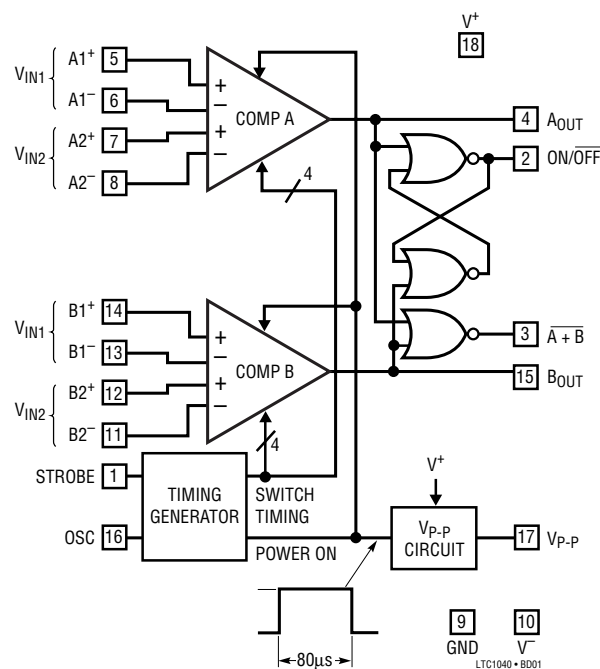
Quick Hookup Guide



TEST CIRCUIT



BLOCK DIAGRAM



APPLICATIONS INFORMATION

The LTC1040 uses sampled data techniques to achieve its unique characteristics. Some of the experience acquired using classic linear comparators does not apply to this circuit, so a brief description of internal operation is essential to proper application.

The most obvious difference between the LTC1040 and other comparators is the dual differential input structure. Functionally, when the sum of inputs is positive, the comparator output is high and when the sum of the inputs is negative, the output is low. This unique input structure is achieved with CMOS switches and a precision capacitor array. Because of the switching nature of the inputs, the concept of input current and input impedance needs to be examined.

The equivalent input circuit is shown in Figure 1. Here, the input is being driven by a resistive source, R_S , with a bypass capacitor, C_S . The bypass capacitor may or may not be needed, depending on the size of the source resistance and the magnitude of the input voltage, V_{IN} .

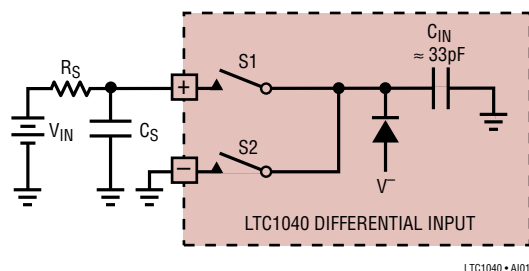


Figure 1. Equivalent Input Circuit

For $R_S < 10k$

Assuming C_S is zero, the input capacitor, C_{IN} , charges to V_{IN} with a time constant of $R_S C_{IN}$. When R_S is too large, C_{IN} does not have a chance to fully charge during the sampling interval ($\approx 80\mu s$) and errors will result. If R_S exceeds $10k\Omega$, a bypass capacitor is necessary to minimize errors.

For $R_S > 10k\Omega$

For R_S greater than $10k\Omega$, C_{IN} cannot fully charge and a bypass capacitor, C_S , is needed. When switch S1 closes, charge is shared between C_S and C_{IN} . The change in voltage on C_S because of this charge sharing is:

$$\Delta V = V_{IN} \cdot \frac{C_{IN}}{C_{IN} + C_S}$$

This represents an error and can be made arbitrarily small by increasing C_S .

With the addition of C_S , a second error term caused by the finite input resistance of the LTC1040 must be considered. Switches S1 and S2 alternately open and close, charging and discharging C_{IN} between V_{IN} and ground. The alternate charge and discharge of C_{IN} causes a current to flow into the positive input and out of the negative input. The magnitude of this current is:

$$I_{IN} = q \cdot f_S = V_{IN} C_{IN} f_S$$

where f_S is the sampling frequency. Because the input current is directly proportional to input voltage, the LTC1040 can be said to have an average input resistance of:

$$R_{IN} = \frac{V_{IN}}{I_{IN}} = \frac{1}{f_S C_{IN}} = \frac{1}{f_S \cdot 33pF}$$

(see typical curve of Input Resistance vs Sampling Frequency). A voltage divider is set up between R_S and R_{IN} causing error.

The input voltage error caused by these two effects is:

$$V_{ERROR} = V_{IN} \left(\frac{C_{IN}}{C_{IN} + C_S} + \frac{R_S}{R_S + R_{IN}} \right)$$

Example: $f_S = 10Hz$, $R_S = 1M\Omega$,
 $C_S = 1\mu F$, $V_{IN} = 1V$

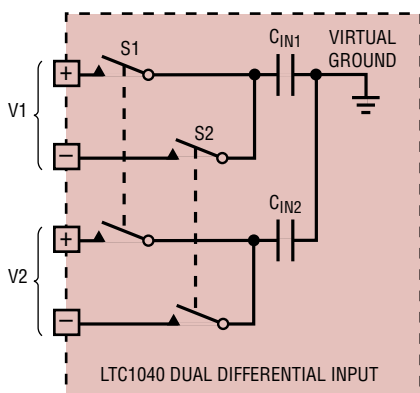
$$\begin{aligned} V_{ERROR} &= 1V \left(\frac{33 \cdot 10^{-12}}{1 \cdot 10^{-6}} + \frac{10^6}{10^6 + 3 \cdot 10^9} \right) \\ &= 33\mu V + 330\mu V = 363\mu V. \end{aligned}$$

Notice that most of the error is caused by R_{IN} . If the sampling frequency is reduced to $1Hz$, the voltage error is reduced to $66\mu V$.

APPLICATIONS INFORMATION

Minimizing Comparison Errors

The two differential input voltages, V_1 and V_2 , are converted to charge by the input capacitors C_{IN1} and C_{IN2} (see Figure 2). The charge is summed at the virtual ground point; if the net charge is positive, the comparator output is high and if negative, it is low. There is an optimum way to connect these inputs, in a specific application, to minimize error.



LTC1040 • A102

Figure 2. Dual Differential Equivalent Input Circuit

Ignoring internal offset, the LTC1040 will be at its switching point when:

$$V_1 \cdot C_{IN1} + V_2 \cdot C_{IN2} = 0.$$

Optimum error will be achieved when the differential voltages, V_1 and V_2 , are individually minimized. Figure 3 shows two ways to connect the LTC1040 to compare an input voltage, V_{IN} , to a reference voltage, V_{REF} . Using the above equation, each method will be at null when:

- (a) $(V_{REF} - 0V) C_{IN1} - (0V - V_{IN}) C_{IN2} = 0$
or $V_{IN} = V_{REF} (C_{IN1}/C_{IN2})$
- (b) $(V_{REF} - V_{IN}) C_{IN1} - (0V - 0V) C_{IN2} = 0$
or $V_{IN} = V_{REF}$.

Notice that in method (a) the null point depends on the ratio of C_{IN1}/C_{IN2} , but method (b) is independent of this ratio. Also, because method (b) has zero differential input voltage, the errors due to finite input resistance are negligible. The LTC1040 has a high accuracy capacitor array and even the non-optimum connection will only result in $\pm 0.1\%$ more error, worst-case compared to the optimum connection.

Tracking Error

Tracking error is caused by the ratio error between C_{IN1} and C_{IN2} and is expressed as a percentage. For example, consider Figure 3a with $V_{REF} = 1V$. Then at null,

$$V_{IN} = V_{REF} \frac{C_{IN1}}{C_{IN2}} = 1V \pm 1mV$$

because C_{IN1} is guaranteed to equal C_{IN2} to within 0.1%.

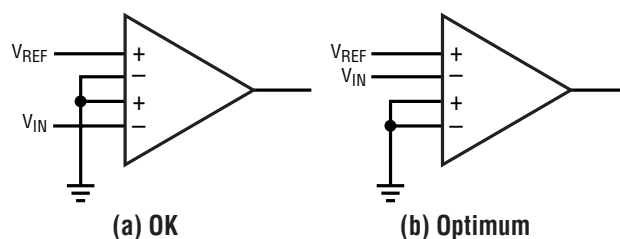
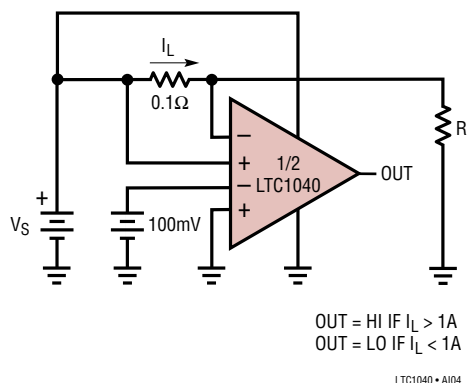


Figure 3. Two Ways to Do It

LTC1040 • TA03

Common Mode Range

The input switches of the LTC1040 are capable of switching to either the V^+ or V^- supply. This means that the input common mode range includes both supply rails. Many applications, not feasible with conventional comparators, are possible with the LTC1040. In the load current detector shown in Figure 4, a 0.1Ω resistor is used to sense the current in the V^+ supply. This application requires the dual differential input and common mode capabilities of the LTC1040.



LTC1040 • A104

Figure 4. Load Current Detector

1040fa

APPLICATIONS INFORMATION

Offset Voltage Error

The errors due to offset, common mode, power supply variation, gain and temperature are all included in the offset voltage specification. This makes it easy to compute the error when using the LTC1040.

Example: error computation for Figure 4.

Assume: $2.8V \leq V_S \leq 6V$.

Then total worst-case error is:

$$I_L(\text{ERROR}) = \pm (100\text{mV} \cdot 0.001 + 0.5\text{mV}) \cdot \frac{1\text{A}}{100\text{mV}} = \pm 6\text{mA}$$

$\uparrow$ $\uparrow$
 Tracking Error V_{OS}

$$I_L(\text{ERROR})\% = \frac{6\text{mA}}{1\text{A}} \cdot 100 = \pm 0.6\%$$

Note: If source resistance exceeds 10k, bypass capacitors should be used and the associated errors must be included.

Pulsed Power (V_{P-P}) Output

It is often desirable to use comparators with resistive networks such as bridges. Because of the extremely low power consumption of the LTC1040, the power consumed by these resistive networks can far exceed that of the device itself.

At low sample rates the LTC1040 spends most of its time off. To take advantage of this, a pulsed power (V_{P-P}) output is provided. V_{P-P} is switched to V^+ when the comparator is on and to a high impedance (open circuit) when the comparator is off. The ON time is nominally 80 μ s. Figure 5 shows the V_{P-P} output circuit.

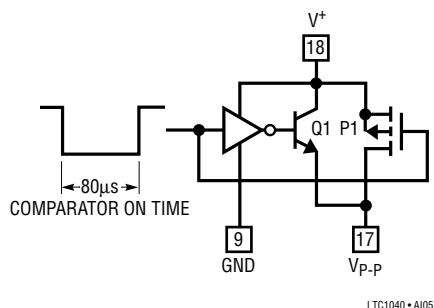


Figure 5. V_{P-P} Output Switch

The V_{P-P} output voltage is not precise (see V_{P-P} Output Voltage versus Load Current curve). There are two ways V_{P-P} can be used to power external networks without excessive errors: (1) ratiometric networks and (2) fast settling references.

In a ratiometric network, the inputs are all proportional to V_{P-P} (see Figure 6). Consequently, for small changes, the absolute value of V_{P-P} does not affect accuracy.

It is critical that the inputs to the LTC1040 completely settle within 4 μ s of the start of the comparison cycle and that they do not change during the 80 μ s ON time. When driving resistive networks with V_{P-P} , capacitive loading on

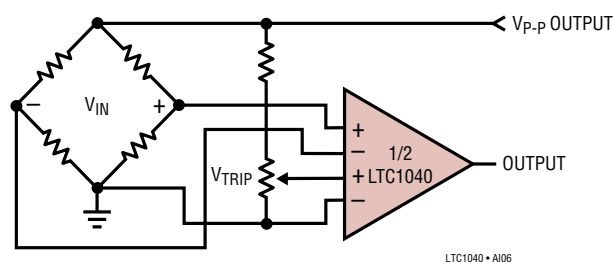


Figure 6. Ratiometric Network Driven by V_{P-P}

the network should be minimized to meet the 4 μ s settling time requirement. It is not recommended that V_{P-P} be used to drive networks with source impedances, as seen by the inputs, of greater than 10k Ω .

In applications where an absolute reference is required, the V_{P-P} output can be used to drive a fast settling reference. The LT1009 2.5V reference, ideal in this application, settles in approximately 2 μ s (see Figure 7). The current through R1 must be large enough to supply the LT1009 minimum bias current ($\approx 1\text{mA}$) and the load current, I_L .

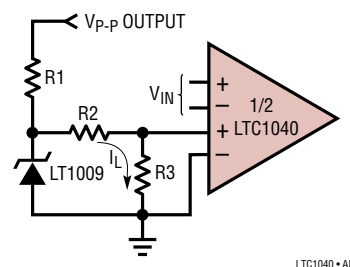


Figure 7. Driving Reference with V_{P-P} Output

APPLICATIONS INFORMATION

Output Logic

In addition to the normal outputs (A_{OUT} and B_{OUT}), two additional outputs, $\overline{A + B}$ and ON/OFF , are provided (see Figure 8 and Table 1). All logic is powered from V^+ and ground, thus input and output logic levels are independent of the V^- supply. The LTC1040 is directly compatible with CMOS logic and is TTL compatible for $4.75V \leq V^+ \leq 5.25V$. No external pull-up resistors are required.

Table 1. Output Logic Truth Table

ΣA INPUTS	ΣB INPUTS	A_{OUT}	B_{OUT}	$\overline{A + B}$	ON/OFF
+	+	H	H	L	L
+	-	H	L	L	L
-	+	L	H	L	H
-	-	L	L	H	I*

*I = indeterminate. When both A and B outputs are low, the ON/OFF output remains in the state it was in prior to entering $A_{OUT} = B_{OUT} = L$.

Using External Strobe

A positive pulse on the strobe input, with the OSC input tied to ground, will initiate a comparison cycle. The $STROBE$ input is edge-sensitive and pulse widths of 50ns will typically trigger the device.

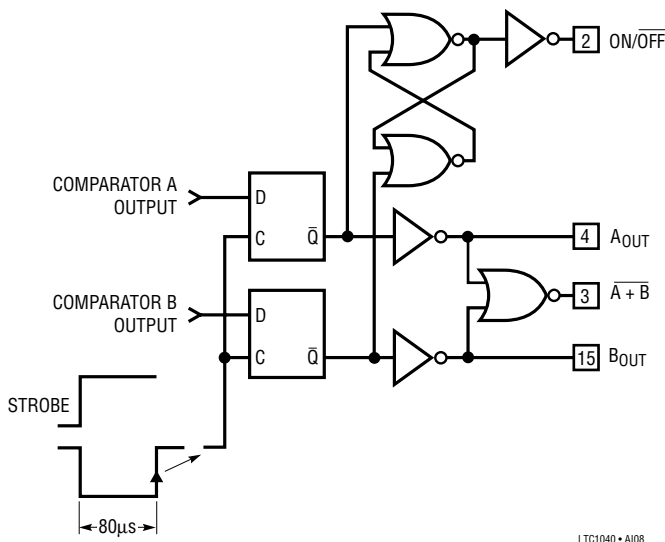


Figure 8. LTC1040 Logic Diagram

Because of the sampling nature of the LTC1040, some sensitivity exists between the offset voltage and the falling edge of the input strobe. When the falling edge of the strobe signal falls within the comparator's active time (80µs after rising edge), offset changes of as much as 2mV can occur. To eliminate this problem, make sure the strobe pulse width is greater than the response time, t_D .

Using Internal Strobe

An internal oscillator allows the LTC1040 to strobe itself. The frequency of oscillation, and hence sampling rate, is set by an external RC network (see typical curve of Sampling Rate vs R_{EXT} , C_{EXT}).

For self-oscillation, the $STROBE$ pin must be tied to ground. The external RC network is connected as shown in Figure 9.

To assure oscillation, R_{EXT} must be between 100k and 10M. There is no limit to the size of C_{EXT} .

R_{EXT} is very important in determining the power consumption. The average voltage at the oscillator pin is approximately $V^+/2$. The power consumed by R_{EXT} is then: $P_{REXT} = (V^+/2)^2/R_{EXT}$.

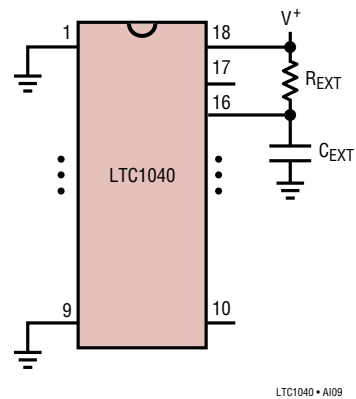


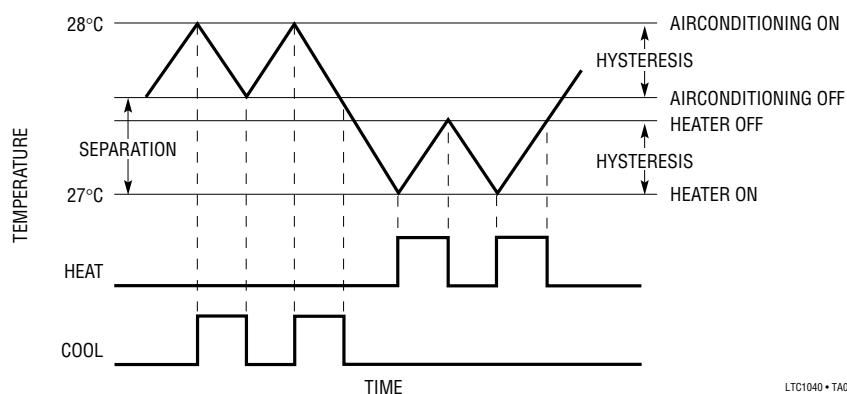
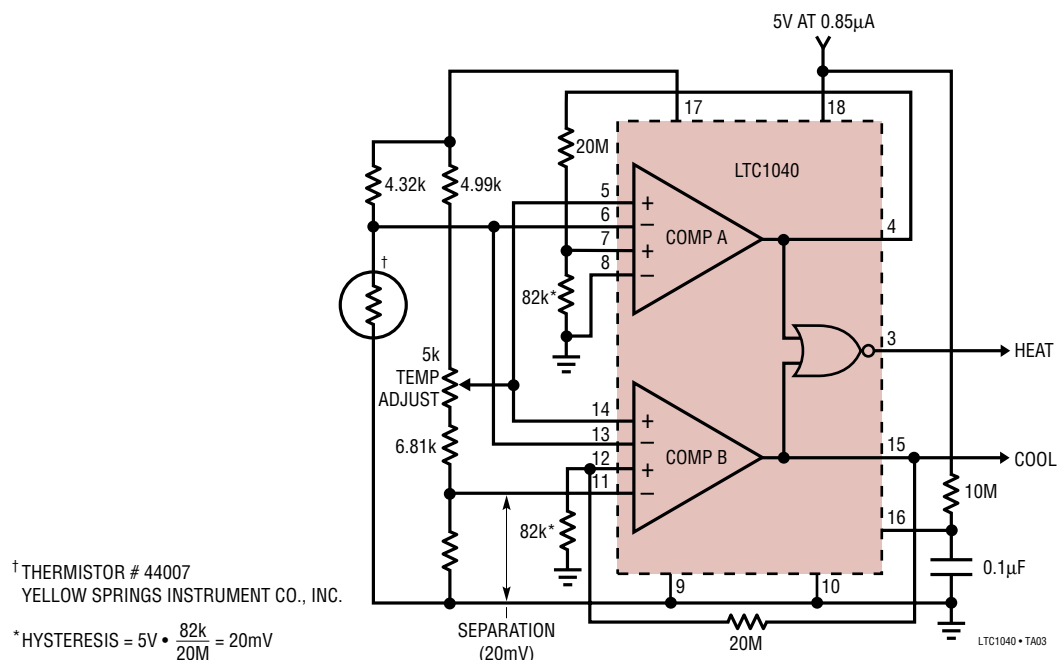
Figure 9. External RC Connection

Example: $R_{EXT} = 1M$, $V^+ = 5V$, $P_{REXT} = (2.5)^2/10^6 = 6.25 \cdot 10^{-6}W$.

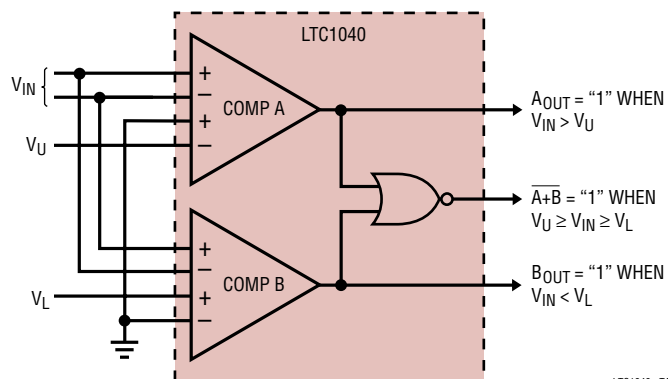
This is about four times the power consumed by the LTC1040 at $V^+ = 5V$ and $f_S = 1$ sample/second. Where power is a premium R_{EXT} should be made as large as possible. Note that the power consumed by R_{EXT} is *not* a function of f_S or C_{EXT} .

TYPICAL APPLICATIONS

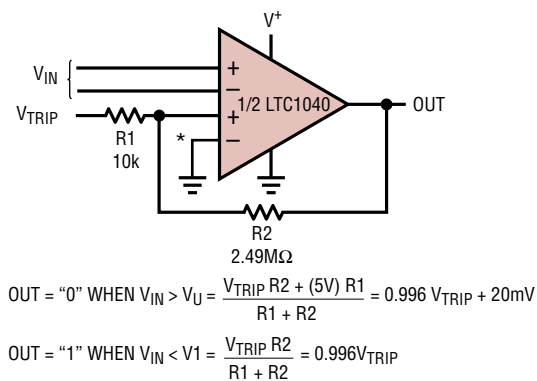
Complete Heating/Cooling Automatic Thermostat



Window Comparator with Independent Window Limits and Fully Floating Differential Input



Hysteresis Comparator with Fully Floating Differential Input



* TO CENTER HYSTERESIS ABOUT V_{TRIP} , FORCE THIS INPUT TO HYSTERESIS/2 (10mV)

LTC1040 • TA06

1040fa

TYPICAL APPLICATIONS

The LTC1040 as a Linear Amplifier

With a simple RC filter, the LTC1040 can be made to function as a linear amplifier. By filtering the logic output and feeding it back to the negative input, the loop forces the output duty cycle $[t_{ON}/(t_{ON} + t_{OFF})]$ so that V_{OUT} equals V_{IN} (Figure 10).

The RC time constant is set to keep the ripple on the output small. The maximum output ripple is: $\Delta V = V^+ / f_S RC$ and

should be set to 0.5mV to 1mV for best results. Notice that the higher the sampling frequency, f_S , the lower RC can be. This is important because the RC filter also sets the loop response. A convenient way to keep f_S as high as possible under all conditions is to connect a 100k resistor to pin 16 (OSC) with no capacitance to ground.

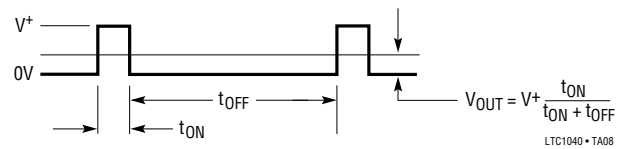
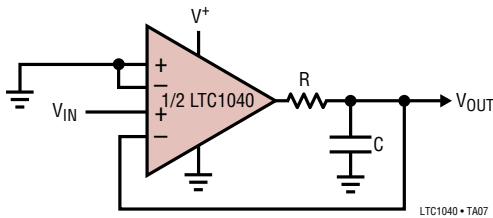
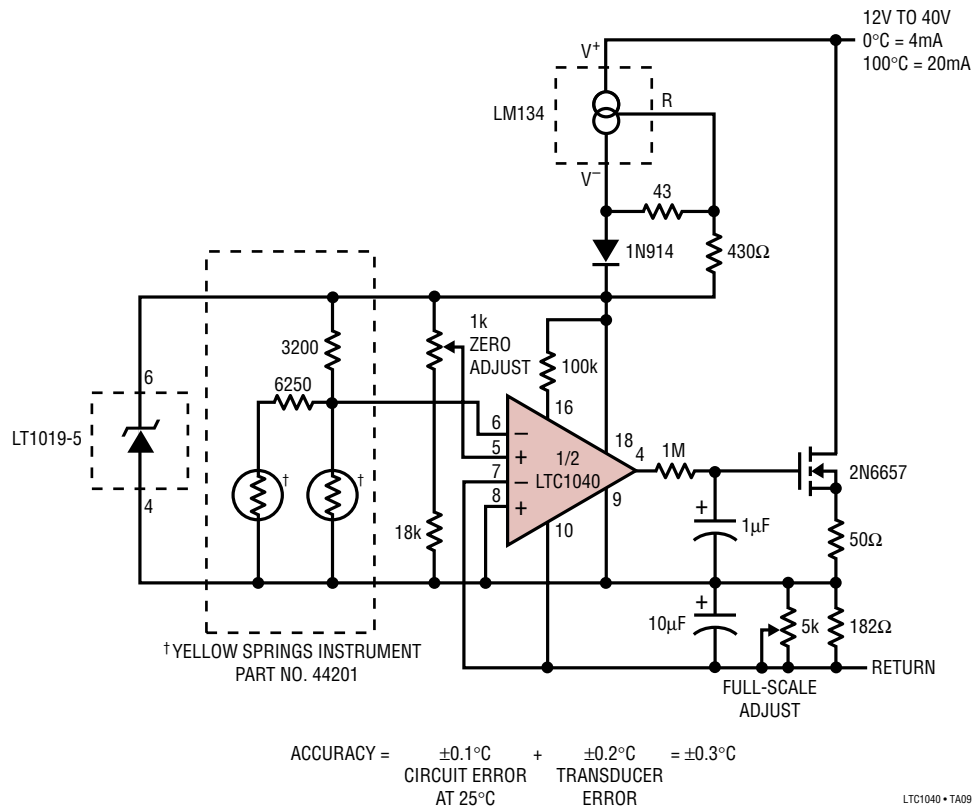


Figure 10. The LTC1040 as a Linear Amplifier

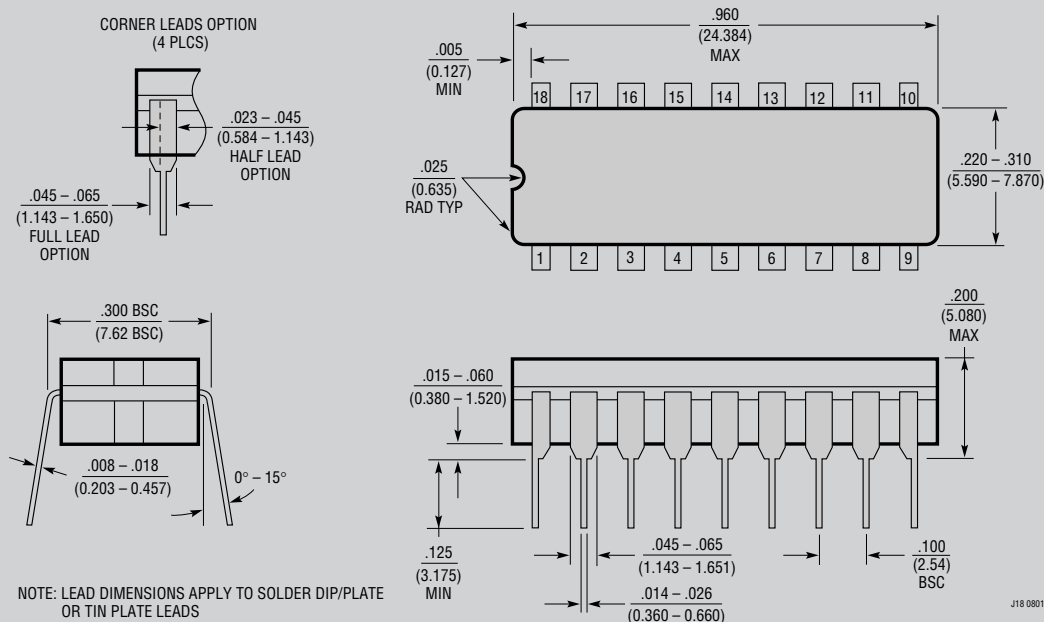
2-Wire 0°C to 100°C Temperature Transducer with 4mA to 20mA Output



LTC1040 • TA09

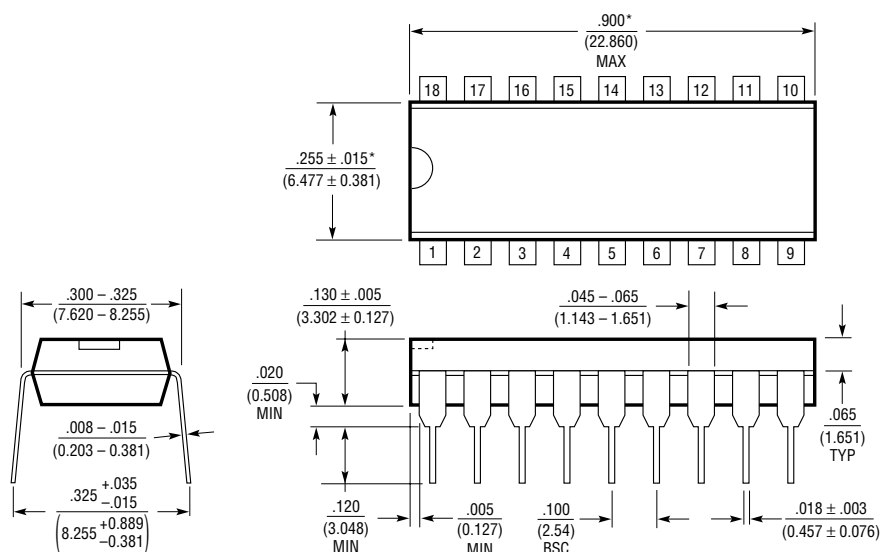
PACKAGE DESCRIPTION

J Package 18-Lead Cerdip (Narrow .300 Inch, Hermetic) (Reference LTC DWG # 05-08-1110)



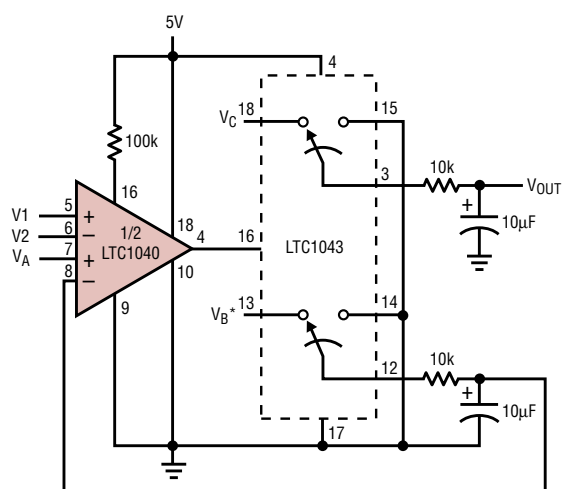
OBSOLETE PACKAGE

N Package 18-Lead PDIP (Narrow .300 Inch) (Reference LTC DWG # 05-08-1510)



TYPICAL APPLICATIONS

Analog Multiplier/Divider

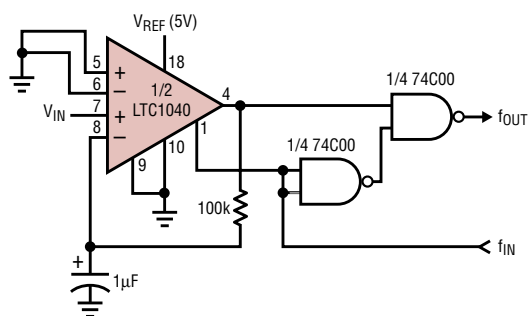


$$V_{OUT} = \frac{(V_A + V_1 - V_2) \cdot V_C}{V_B}$$

ACCURACY = $\pm 10\text{mV}$ NO TRIM
* V_B MUST BE $> V_A + (V1 - V2)$

LTC1040 • TA10

Single + 5V Voltage-to-Frequency Converter

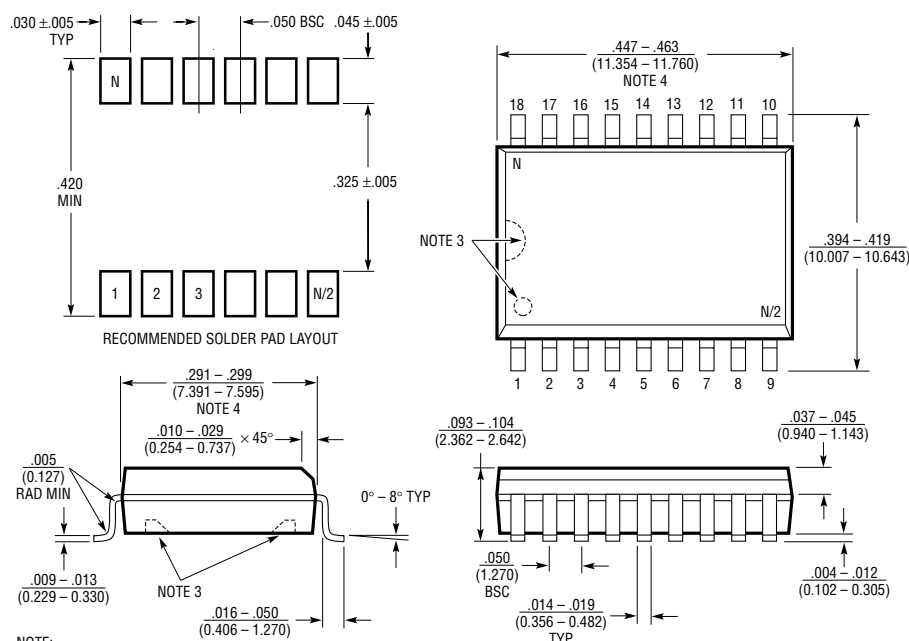


$$f_{OUT} \text{ (AVERAGE)} = f_{IN} \frac{V_{IN}}{V_{REF}} \pm 0.1\% \text{ FS}$$

LTC1040 • TA11

PACKAGE DESCRIPTION

SW Package
18-Lead Plastic Small Outline (Wide .300 Inch)
 (Reference LTC DWG # 05-08-1620)



- NOTE: (0.406 - 1.270) INCHES (10.3 - 32.27) TYP
1. DIMENSIONS IN INCHES
(MILLIMETERS)
2. DRAWING NOT TO SCALE
3. PIN 1 IDENT, NOTCH ON TOP AND CAVITIES ON THE BOTTOM OF PACKAGES ARE THE MANUFACTURING OPTIONS.
THE PART MAY BE SUPPLIED WITH OR WITHOUT ANY OF THE OPTIONS
4. THESE DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.
MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED .006" (0.15mm)

S18 (WIDE) 050